

<b>Notice of References Cited</b>	Application/Control No. 10/812,075	Applicant(s)/Patent Under Reexamination SEKIGUCHI ET AL.	
	Examiner Cecilia M. Jaisle	Art Unit 1624	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,101,878	09-2006	Anderson et al.	514/231.5
*	B	US-7,012,077	03-2006	Ackermann et al.	514/275
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 2002030891	04-2002	WIPO	Yasuda, et al.	
	O					
	P					
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	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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	X	

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